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Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
217075US2PCTSERIAL NO.
10/031,570

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Joseph T. VERDEYEN, et al.

FILING DATE

January 22, 2002

GROUP

2133 1765

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
W	AA	2,405,229	8-6-1946	MUELLER et al.			
	AB	2,483,189	9-27-1949	C. C. EAGLESFIELD			
	AC	2,735,941	2-21-1956	R. C. PECK			
	AD	2,971,153	2-7-1961	WHARTON et al.			
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	AM	3,509,452	4-28-1970	C. W. E. WALKER			
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W	AO	0 432 573	6-19-1991	EUROPE	
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	AQ	WO 01/37306	5-25-2001	WIPO	
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W	AW	P. K. Atrey et al., "Measurement of chord averaged electron density in ADITYA using 100 GHz and 136 GHz interferometers", Indian J. Physics 66B (5 & 6), 1992, pp. 489-97.	
	AX	D. Bora et al., "Plasma density measurement using a simple microwave technique", Rev. Sci. Instrum. 59 (10), 10/1988, pp. 2149-51.	
	AY	D. Bora et al., "A simple microwave technique for plasma density measurement using frequency modulation", Plasma Physics and Controlled Fusion 26 (7), 1984, pp. 853-7.	
	AZ	Nils Brenning, "An improved microwave interferometer technique for plasma density measurements", J. Phys. E: Sci. Instrum. 21, 1988, pp. 578-82.	<input type="checkbox"/> Additional References sheet(s) attached

Examiner

Date Considered

5/27/04

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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 217075US2PCT		SERIAL NO. 10/031,570	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Joseph T. VERDEYEN, et al.		GROUP 2133 1765-000	
				FILING DATE January 22, 2002			
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
[Signature]	AA	3,699,475	10-17-1972	R. G. ROGERS			
	AB	3,899,752	8-12-1975	H. F. ENGELMANN			
	AC	3,956,695	5-11-1976	M. E. STAMM			
	AD	4,034,312	7-5-1977	M. ARMAND			
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	AN	3,572,948	3-30-1971	J. M. CATHERIN			
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[Signature]	AW	N. Brenning, "An improved microwave interferometer technique for plasma density measurements", J. Phys. E: Sci. Instrum. 17, 1984, pp. 1018-23.					
	AX	M. A. G. Calderon et al., "Experimental study of a swept reflectometer with a single antenna for plasma density profile measurement", International Journal of Infrared and Millimeter Waves 6 (7), 1985, pp. 605-28.					
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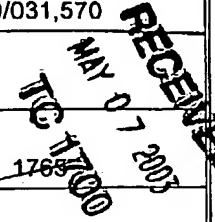
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JH	AA	5,691,642	11-25-1997	D. M. DOBKIN			
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	AC	5,621,331	4-15-1997	SMITH et al.			
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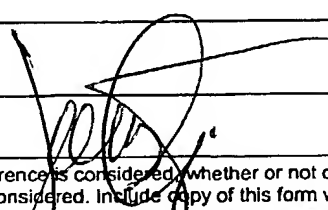
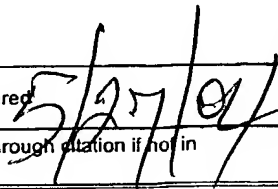
[Signature]	AW	J. A. Fessey et al., "Plasma electron density measurements from the JET 2 mm wave interferometer", J. Phys. E: Sci. Instrum. 20, 1987, pp. 169-74.	<input type="checkbox"/> Additional References sheet(s) attached
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		AAB		J. R. Wallington et al., "A sensitive microwave interferometer for plasma diagnostics", J. Plasma Physics 3 (part 3), 1969, pp. 371-5.			
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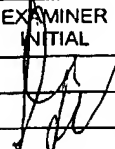
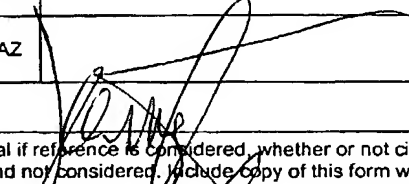
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SHEET 1 OF 1

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Examiner 					<input type="checkbox"/> Additional References sheet(s) attached		
					Date Considered 5/27/02		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							